

## FEATURES

Single 0.8V to 5.5V Operation Supply current: 0.6µA (typ) Input Bias Current: 2pA (typ) Low TCV<sub>OS</sub>: 9µV/°C (typ) Avol Driving 100kΩ Load: 90dB (min) Gain-Bandwidth Product: 4kHz Unity Gain Stable Rail-to-rail Input and Output No Output Phase Reversal 5-pin SC70 or 5-pin SOT23 Packaging

### APPLICATIONS

Battery/Solar-Powered Instrumentation Portable Gas Monitors Low-voltage Signal Processing **Micropower Active Filters** Wireless Remote Sensors Battery-powered Industrial Sensors Active **RFID** Readers Powerline or Battery Current Sensing Handheld/Portable POS Terminals

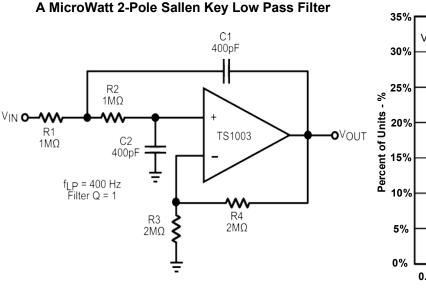
# **TYPICAL APPLICATION CIRCUIT**

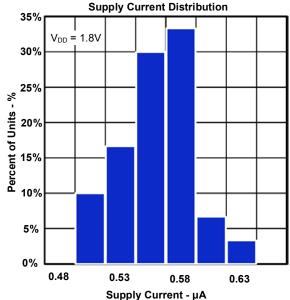
# DESCRIPTION

The TS1003 is the industry's first sub-1µA supply current, precision CMOS operational amplifier fully specified to operate over a supply voltage range from 0.8V to 5.5V. Fully specified at 1.8V, the TS1003 is optimized for ultra-long-life batterv powered applications. The TS1003 is the fourth operational "NanoWatt Analog™" amplifier in the hiahperformance analog integrated circuits portfolio. The TS1003 exhibits a typical input bias current of 2pA, and has rail-to-rail input and output stages.

The TS1003's combined features make it an excellent choice in applications where very low supply current and low operating supply voltage translate into very long equipment operating time. Applications include: micropower active filters, wireless remote sensors, battery and powerline current sensors, portable gas monitors, and handheld/portable POS terminals.

The TS1003 is fully specified over the industrial temperature range (-40°C to +85°C) and is available in either a PCB-space saving 5-lead SC70 or a 5-lead SOT23 packaging.







## **ABSOLUTE MAXIMUM RATINGS**

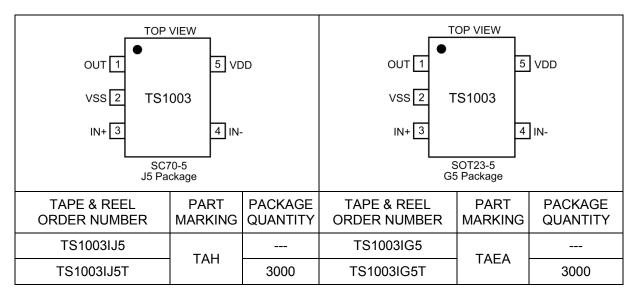
Total Supply Voltage (V <sub>DD</sub> to V <sub>SS</sub> )	+6.0V
Voltage Inputs (IN+, IN-) (V <sub>SS</sub> - 0.3V) to	
Differential Input Voltage	±6.0 V
Input Current (IN+, IN-)	20 mA
Output Short-Circuit Duration to GND	Indefinite
Continuous Power Dissipation ( $T_A = +70^{\circ}C$ )	
5-Pin SC70 (Derate 3.87mW/°C above +70°C)	) 310 mW

5-Pin SOT23(Derate 3.87mW/°C above +70°C).... 312 mW

Operating Temperature Range	40°C to +85°C
Junction Temperature	+150°C
Storage Temperature Range	65°C to +150°C
Lead Temperature (soldering, 10s)	+300°

Electrical and thermal stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other condition beyond those indicated in the operational sections of the specifications is not implied. Exposure to any absolute maximum rating conditions for extended periods may affect device reliability and lifetime.

## PACKAGE/ORDERING INFORMATION



Lead-free Program: Silicon Labs supplies only lead-free packaging.

Consult Silicon Labs for products specified with wider operating temperature ranges.



### **ELECTRICAL CHARACTERISTICS**

 $V_{DD}$  = +1.8V,  $V_{SS}$  = 0V,  $V_{INCM}$  =  $V_{SS}$ ;  $R_L$  = 100k $\Omega$  to ( $V_{DD}$ - $V_{SS}$ )/2;  $T_A$  = -40°C to +85°C, unless otherwise noted. Typical values are at  $T_A$  = +25°C. See Note 1

Parameters	Symbol	Conditions		Min	Тур	Max	Units
Supply Voltage Range	V <sub>DD</sub> -V <sub>SS</sub>			0.8		5.5	V
Supply Current	I	T <sub>A</sub> = 25°C			0.6	0.8	
	I <sub>SY</sub>	R <sub>L</sub> = Open circuit	-40°C ≤ T <sub>A</sub> ≤ 85°C			1	μA
	Vos		T <sub>A</sub> = 25°C		0.8	3	mV
Input Offset Voltage		$V_{IN} = V_{SS} \text{ or } V_{DD}$	-40°C ≤ T <sub>A</sub> ≤ 85°C			5	
Input Offset Voltage Drift	TCVos		•		9		μV/°C
Input Bias Current	I <sub>IN+</sub> , I <sub>IN-</sub>	$V_{IN*}, V_{IN-} = (V_{DD} - V_{SS})/2$	T <sub>A</sub> = 25°C		2		– pA
Input bias Current	11N+, 11N-		-40°C ≤ T <sub>A</sub> ≤ 85°C			100	
Input Offset Current	laa	Specified as IIN+ - IIN-	T <sub>A</sub> = 25°C		2		рА
Input Offset Current	los	V <sub>IN+</sub> , V <sub>IN-</sub> = (V <sub>DD</sub> - V <sub>SS</sub> )/2	$-40^{\circ}C \le T_A \le 85^{\circ}C$			50	
Input Voltage Range	IVR	Guaranteed by Input Offset Voltage Test		Vss		V <sub>DD</sub>	V
Common-Mode Rejection Ratio	CMRR	$Vdd=5.5V; 0V \le V_{IN(CM)} \le 5.0V$	T <sub>A</sub> = 25°C	70	90		dB
	CIVILAR	Vdd-5.5V, 0V = VIN(CM) = 5.0V	-40°C ≤ T <sub>A</sub> ≤ 85°C	68			
Power Supply Rejection Ratio	PSRR	$0.8 V \leq (V_{DD} - V_{SS}) \leq 5.5 V$	T <sub>A</sub> = 25°C	70	90		dB
	1 OKK		$-40^{\circ}C \le T_A \le 85^{\circ}C$	67			UD
		Specified as V <sub>DD</sub> - V <sub>OUT</sub> ,	T <sub>A</sub> = 25°C		3.7		mV
Output Voltage High	V <sub>OH</sub>	$R_L$ = 100k $\Omega$ to $V_{SS}$	-40°C ≤ T <sub>A</sub> ≤ 85°C			6	
Output Voltage High		Specified as VDD - VOUT,	T <sub>A</sub> = 25°C		30		
		$R_L$ = 10k $\Omega$ to V <sub>SS</sub>	$-40^{\circ}C \le T_A \le 85^{\circ}C$			60	
		Specified as VOUT - VSS,	T <sub>A</sub> = 25°C		1.5		
Output Voltage Low	V <sub>OL</sub>	$R_L$ = 100k $\Omega$ to $V_{DD}$	$-40^{\circ}C \le T_A \le 85^{\circ}C$			6	mV
		Specified as $V_{OUT}$ - $V_{SS}$ , R <sub>L</sub> = 10k $\Omega$ to $V_{DD}$	T <sub>A</sub> = 25°C		15		
			-40°C ≤ T <sub>A</sub> ≤ 85°C			30	
	I <sub>SC+</sub>	Vout = Vss	T <sub>A</sub> = 25°C		4		
Short-circuit Current	ISC+	Vout - Vss	-40°C ≤ T <sub>A</sub> ≤ 85°C	2			- mA
Short-circuit Gurrent	Isc-	V <sub>OUT</sub> = V <sub>DD</sub>	T <sub>A</sub> = 25°C		15		
	ISC- V		$-40^{\circ}C \le T_A \le 85^{\circ}C$	7			
Open-loop Voltage Gain	A	A <sub>VOL</sub> $V_{SS}$ +50mV $\leq V_{OUT} \leq V_{DD}$ -50mV	T <sub>A</sub> = 25°C	91	110		dB
Open-loop voltage Gain	AVOL		$-40^{\circ}C \le T_A \le 85^{\circ}C$	84			aв
Gain-Bandwidth Product	GBWP	$R_L$ = 100k $\Omega$ to V <sub>SS</sub> , $C_L$ = 20pF			4		kHz
Phase Margin	Фм	Unity-gain Crossover, $R_L = 100k\Omega$ to V <sub>SS</sub> , $C_L = 20pF$			70		degrees
Slew Rate	SR	$R_L = 100 k\Omega$ to $V_{SS}$ , $A_{VCL} = +1 V/V$			1.5		V/ms
Full-power Bandwidth	FPBW	FPBW = SR/(π • V <sub>OUT,PP</sub> ); V <sub>OUT,PF</sub>	= 0.7V <sub>PP</sub>		680		Hz
Input Voltage Noise Density	en	f = 1kHz			0.6		µV/√Hz
Input Current Noise Density	İn	f = 1kHz			10		pA/√H

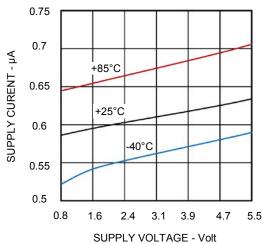
Note 1: All specifications are 100% tested at T<sub>A</sub> = +25°C. Specification limits over temperature (T<sub>A</sub> = T<sub>MIN</sub> to T<sub>MAX</sub>) are guaranteed by device characterization, not production tested.



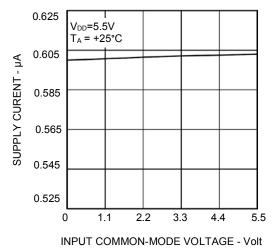
## **TYPICAL PERFORMANCE CHARACTERISTICS**

Supply Current vs Supply Voltage

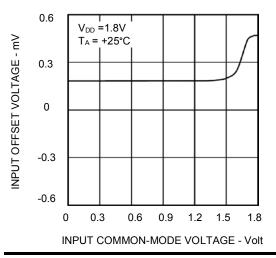
Supply Current vs Input Common-Mode Voltage

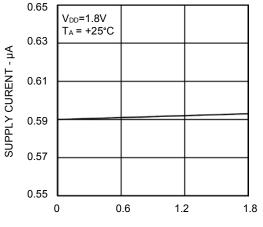


Supply Current vs Input Common-Mode Voltage



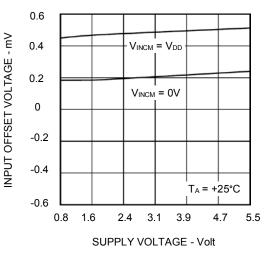
Input Offset Voltage vs Input Common-Mode Voltage



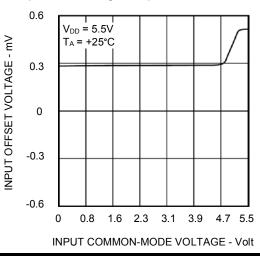


INPUT COMMON-MODE VOLTAGE - Volt

Input Offset Voltage vs Supply Voltage



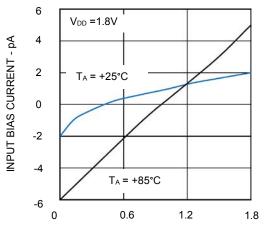
Input Offset Voltage vs Input Common-Mode Voltage





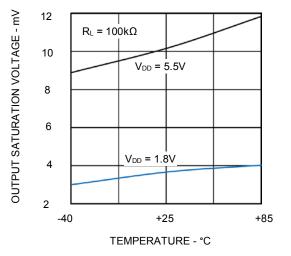
### **TYPICAL PERFORMANCE CHARACTERISTICS**

Input Bias Current (I\_{IN+}, I\_{IN-}) vs Input Common-Mode Voltage

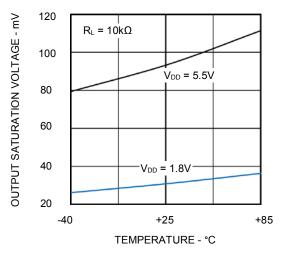


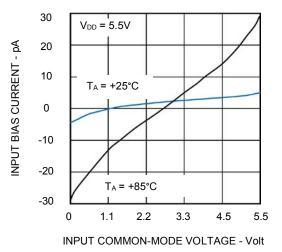
INPUT COMMON-MODE VOLTAGE - Volt

#### Output Voltage High (V\_OH) vs Temperature, $R_{\text{LOAD}}$ =100k $\Omega$



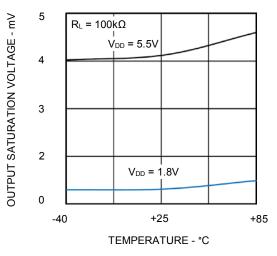
Output Voltage High (V<sub>OH</sub>) vs Temperature, R<sub>LOAD</sub> =10k $\Omega$ 



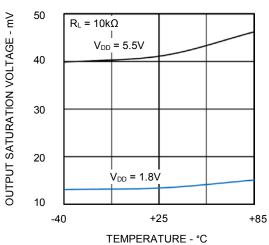


Input Bias Current (I<sub>IN+</sub>, I<sub>IN-</sub>) vs Input Common-Mode Voltage

#### Output Voltage Low (V<sub>OL</sub>) vs Temperature, $R_{LOAD}$ =100k $\Omega$

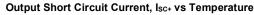


#### Output Voltage Low (VoL) vs Temperature, $R_{LOAD}$ =10k $\Omega$

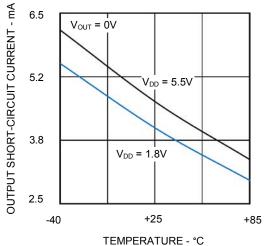




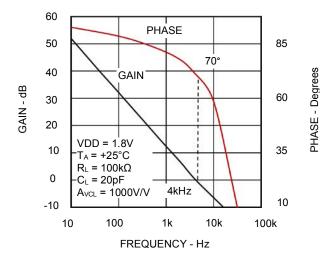
## **TYPICAL PERFORMANCE CHARACTERISTICS**

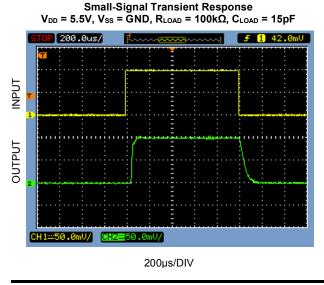


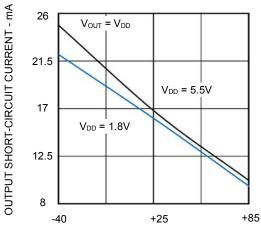
Output Short Circuit Current, Isc. vs Temperature



Gain and Phase vs. Frequency

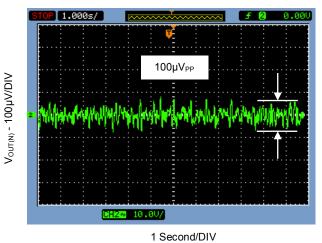




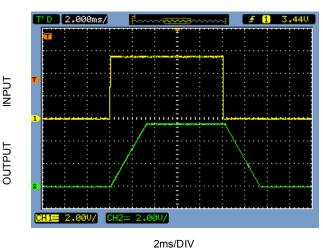


TEMPERATURE - °C

0.1Hz to 10Hz Output Voltage Noise



 $\label{eq:Large-Signal Transient Response} $$V_{DD} = 5.5V, V_{SS} = GND, R_{LOAD} = 100 k\Omega, C_{LOAD} = 15 pF$$ 



## **PIN FUNCTIONS**

Pin	Label	Function
1	OUT	Amplifier Output.
2	Vss	Negative Supply or Analog GND. If applying a negative voltage to this pin, connect a $0.1\mu$ F capacitor from this pin to analog GND.
3	+IN	Amplifier Non-inverting Input.
4	-IN	Amplifier Inverting Input.
5	V <sub>DD</sub>	Positive Supply Connection. Connect a 0.1µF bypass capacitor from this pin to analog GND.

### THEORY OF OPERATION

The TS1003 is fully functional for an input signal from the negative supply (Vss or GND) to the positive supply (V<sub>DD</sub>). The input stage consists of two differential amplifiers, a p-channel CMOS stage and an n-channel CMOS stage that are active over different ranges of the input common mode voltage. The p-channel input pair is active for input common mode voltages, V<sub>INCM</sub>, between the negative supply to approximately 0.4V below the positive supply. As the common-mode input voltage moves closer towards V<sub>DD</sub>, an internal current mirror activates the n-channel input pair differential pair. The p-channel input pair becomes inactive for the balance of the input common mode voltage range up to the positive supply. Because both input stages have their own offset voltage (Vos) characteristic, the offset voltage of the TS1003 is a function of the applied input common-mode voltage,  $V_{\text{INCM}}.$  The  $V_{\text{OS}}$  has a crossover point at ~0.4V from  $V_{\text{DD}}$  (Refer to the  $V_{\text{OS}}$ Vсм curve in the Typical Operating VS. Characteristics section). Caution should be taken in applications where the input signal amplitude is comparable to the TS1003's Vos value and/or the

design requires high accuracy. In these situations, it is necessary for the input signal to avoid the crossover point. In addition, amplifier parameters such as PSRR and CMRR which involve the input offset voltage will also be affected by changes in the input common-mode voltage across the differential pair transition region.

The second stage is a folded-cascode transistor arrangement that converts the input stage differential signals into a single-ended output. A complementary drive generator supplies current to the output transistors that swing rail to rail.

The TS1003 output stages voltage swings within 3.7mV from the rails at 1.8V supply when driving an output load of  $100k\Omega$  - which provides the maximum possible dynamic range at the output. This is particularly important when operating on low supply voltages. When driving a stiffer  $10k\Omega$  load, the TS1003 swings within 30mV of VDD and within 13mV of Vss or GND.

# **APPLICATIONS INFORMATION**

#### **Portable Gas Detection Sensor Amplifier**

Gas sensors are used in many different industrial and medical applications. Gas sensors generate a current that is proportional to the percentage of a particular gas concentration sensed in an air sample. This output current flows through a load resistor and the resultant voltage drop is amplified. Depending on the sensed gas and sensitivity of the sensor, the output current can be in the range of tens of microamperes to a few milliamperes. Gas sensor datasheets often specify a recommended

load resistor value or a range of load resistors from which to choose.

There are two main applications for oxygen sensors - applications which sense oxygen when it is abundantly present (that is, in air or near an oxygen tank) and those which detect traces of oxygen in parts-per-million concentration. In medical applications, oxygen sensors are used when air quality or oxygen delivered to a patient needs to be monitored. In fresh air, the concentration of oxygen is 20.9% and air samples containing less than 18% oxygen are considered dangerous. In industrial applications, oxygen sensors are used to detect the



absence of oxygen; for example, vacuum-packaging of food products is one example.

The circuit in Figure 1 illustrates a typical implementation used to amplify the output of an oxygen detector. The TS1003 makes an excellent choice for this application as it only draws  $0.6\mu$ A of supply current and operates on supply voltages

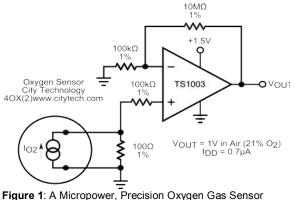


Figure 1: A Micropower, Precision Oxygen Gas Sensor Amplifier.

down to 0.8V. With the components shown in the figure, the circuit consumes less than 0.7 µA of supply current ensuring that small form-factor singleor button-cell batteries (exhibiting low mAh charge ratings) could last beyond the operating life of the oxygen sensor. The precision specifications of the TS1003, such as its low offset voltage, low TCV<sub>OS</sub>, low input bias current, high CMRR, and high PSRR are other factors which make the TS1003 an excellent choice for this application. Since oxygen sensors typically exhibit an operating life of one to two years, an oxygen sensor amplifier built around a TS1003 can operate from a conventionally-available single 1.5-V alkaline AA battery for over 290 years! At such low power consumption from a single cell, the oxygen sensor could be replaced over 150 times before the battery requires replacing!

#### MicroWatt, Buffered Single-pole Low-Pass Filters

When receiving low-level signals, limiting the bandwidth of the incoming signals into the system is often required. As shown in Figure 2, the simplest

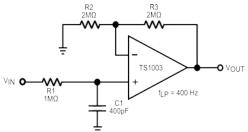


Figure 2: A Simple, Single-pole Active Low-Pass Filter.

way to achieve this objective is to use an RC filter at the noninverting terminal of the TS1003.

If additional attenuation is needed, a two-pole Sallen-Key filter can be used to provide the additional attenuation as shown in Figure 3.

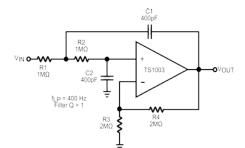


Figure 3: A Micropower 2-Pole Sallen-Key Low-Pass Filter.

For best results, the filter's cutoff frequency should be 8 to 10 times lower than the TS1003's crossover frequency. Additional operational amplifier phase margin shift can be avoided if the amplifier bandwidth-to-signal bandwidth ratio is greater than 8.

The design equations for the 2-pole Sallen-Key lowpass filter are given below with component values selected to set a 400Hz low-pass filter cutoff frequency:

R1 = R2 = R =  $1M\Omega$ C1 = C2 = C = 400pFQ = Filter Peaking Factor = 1 f-3dB =  $1/(2 \times \pi \times RC) = 400$  Hz R3 = R4/(2-1/Q); with Q = 1, R3 = R4.

# A Single +1.5 V Supply, Two Op Amp Instrumentation Amplifier

The TS1003's ultra-low supply current and ultra-low voltage operation make it ideal for battery-powered applications such as the instrumentation amplifier shown in Figure 4.

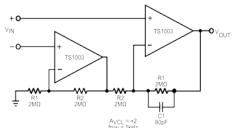


Figure 4: A Two Op Amp Instrumentation Amplifier.



The circuit utilizes the classic two op amp instrumentation amplifier topology with four resistors to set the gain. The equation is simply that of a noninverting amplifier as shown in the figure. The two resistors labeled R1 should be closely matched to each other as well as both resistors labeled R2 to ensure acceptable common-mode rejection performance.

Resistor networks ensure the closest matching as well as matched drifts for good temperature stability. Capacitor C1 is included to limit the bandwidth and, therefore, the noise in sensitive applications. The value of this capacitor should be adjusted depending on the desired closed-loop bandwidth of the instrumentation amplifier. The RC combination creates a pole at a frequency equal to  $1/(2\pi \times R1C1)$ . If the AC-CMRR is critical, then a matched capacitor to C1 should be included across the second resistor labeled R1.

Because the TS1003 accepts rail-to-rail inputs, the input common mode range includes both ground and the positive supply of 1.5V. Furthermore, the rail-to-rail output range ensures the widest signal range possible and maximizes the dynamic range of the system. Also, with its low supply current of  $0.6\mu$ A, this circuit consumes a quiescent current of only ~1.3 $\mu$ A, yet it still exhibits a 1-kHz bandwidth at a circuit gain of 2.

#### **Driving Capacitive Loads**

While the TS1003's internal gain-bandwidth product is 4kHz, it is capable of driving capacitive loads up to 50pF in voltage follower configurations without any additional components. In many applications, however, an operational amplifier is required to drive much larger capacitive loads. The amplifier's output impedance and a large capacitive load create additional phase lag that further reduces the amplifier's phase margin. If enough phase delay is introduced, the amplifier's phase margin is reduced. The effect is quite evident when the transient response is observed as there will appear noticeable peaking/ringing in the output transient response.

If the TS1003 is used in an application that requires driving larger capacitive loads, an isolation resistor between the output and the capacitive load should be used as illustrated in Figure 5.

Table 1 illustrates a range of  $R_{ISO}$  values as a function of the external  $C_{LOAD}$  on the output of the TS1003. The power supply voltage used on the

TS1003 at which these resistor values were determined empirically was 1.8V. The oscilloscope capture shown in Figure 6 illustrates a typical transient response obtained with a  $C_{LOAD}$  = 100pF and an  $R_{ISO}$  = 120k $\Omega$ . Note that as  $C_{LOAD}$  is increased a smaller  $R_{ISO}$  is needed for optimal transient response.

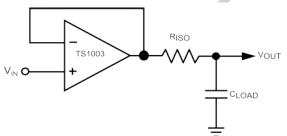
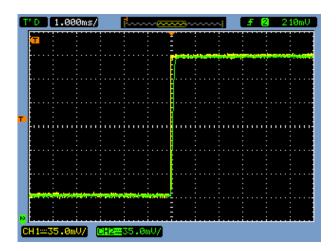


Figure 5: Using an External Resistor to Isolate a  $C_{\mbox{\scriptsize LOAD}}$  from the TS1003's Output

External Capacitive Load, C <sub>LOAD</sub>	External Output Isolation Resistor, R <sub>ISO</sub>
0-50pF	Not Required
100pF	120kΩ
500pF	50kΩ
1nF	33kΩ
5nF	18kΩ
10nF	13kΩ

In the event that an external  $R_{LOAD}$  in parallel with  $C_{LOAD}$  appears in the application, the use of an  $R_{ISO}$  results in gain accuracy loss because the external series  $R_{ISO}$  forms a voltage-divider with the external load resistor  $R_{LOAD}$ .





# Configuring the TS1003 as Microwatt Analog Comparator

Although optimized for use as an operational amplifier, the TS1003 can also be used as a rail-to-rail I/O comparator as illustrated in Figure 7.

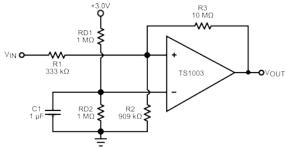
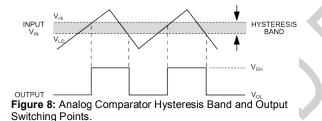


Figure 7: A MicroWatt Analog Comparator with User-Programmable Hysteresis.

External hysteresis can be employed to minimize the risk of output oscillation. The positive feedback circuit causes the input threshold to change when the output voltage changes state. The diagram in Figure 8 illustrates the TS1003's analog comparator



hysteresis band and output transfer characteristic.

The design of an analog comparator using the TS1003 is straightforward. In this application, a 3-V power supply ( $V_{DD}$ ) was used and the resistor divider network formed by RD1 and RD2 generated a convenient reference voltage ( $V_{REF}$ ) for the circuit at  $\frac{1}{2}$  the supply voltage, or 1.5V, while keeping the current drawn by this resistor divider low. Capacitor C1 is used to filter any extraneous noise that could couple into the TS1003's inverting input.

In this application, the desired hysteresis band was set to 100mV (V<sub>HYB</sub>) with a desired high trip-point (V<sub>H</sub>) set at 2.1V and a desired low trip-point (V<sub>LO</sub>) set at 2V.

Since the TS1003 is a very low supply current amplifier ( $0.6\mu A$ , typical), it is desired that the design

of an analog comparator using the TS1003 should also use as little current as practical. The first step in the design, therefore, was to set the feedback resistor R3:

R3 = 10MΩ

Calculating a value for R1 is given by the following expression:

 $R1 = R3 x (V_{HYB}/V_{DD})$ 

Substituting  $V_{HYB}$  = 100mV,  $V_{DD}$  = 3V, and R3 = 10M $\Omega$  into the equation above yields:

R1 = 333 kΩ

The following expression was then used to calculate a value for R2:

 $R2 = 1/[V_{HI}/(V_{REF} \times R1) - (1/R1) - (1/R3)]$ 

Substituting V<sub>HI</sub> = 2.1V, V<sub>REF</sub> = 1.5V, R1 =  $333k\Omega$ , and R3 =  $10M\Omega$  into the above expression yields:

R2 = 909 kΩ

#### Printed Circuit Board Layout Considerations

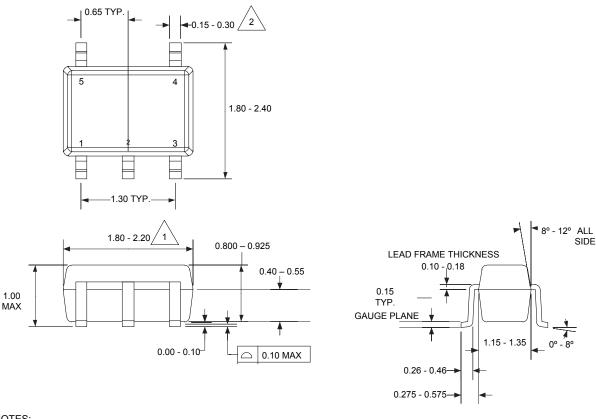
Even though the TS1003 operates from a single 0.8V to 5.5V power supply and consumes very little supply current, it is always good engineering practice to bypass the power supplies with a  $0.1\mu$ F ceramic capacitor placed in close proximity to the V<sub>DD</sub> and V<sub>SS</sub> (or GND) pins.

Good pcb layout techniques and analog ground plane management improve the performance of any analog circuit by decreasing the amount of stray capacitance that could be introduced at the op amp's inputs and outputs. Excess stray capacitance can easily couple noise into the input leads of the op amp and excess stray capacitance at the output will add to any external capacitive load. Therefore, PC board trace lengths and external component leads should be kept a short as practical to any of the TS1003's package pins. Second, it is also good engineering practice to route/remove any analog ground plane from the inputs and the output pins of the TS1003.



PACKAGE OUTLINE DRAWING

5-Pin SC70 Package Outline Drawing (N.B., Drawings are not to scale)



NOTES:

DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. 1

2 DOES NOT INCLUDE INTER-LEAD FLASH OR PROTRUSIONS.

- DIE IS FACING UP FOR MOLDING. DIE IS FACING DOWN FOR TRIM/FORM. 3
- ALL SPECIFICATION COMPLY TO JEDEC SPEC MO-203 AA 4
- CONTROLLING DIMENSIONS IN MILIMITERS. 5.
- ALL SPECIFICATIONS REFER TO JEDEC MO-203 AA 6.
- LEAD SPAN/STAND OFF HEIGHT/COPLANARITY ARE CONSIDERED AS SPECIAL CHARACTERISTIC 7.

0.30 - 0.50



### PACKAGE OUTLINE DRAWING

2.60 - 3.00

.50 - 1.75

2.80 - 3.00 5

0.95 | 0.950

1.90 Max

TYP TYP

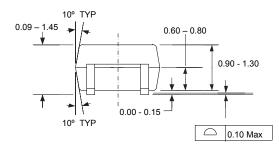


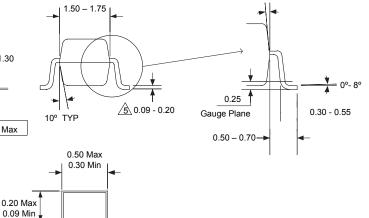
(N.B., Drawings are not to scale)

NOTES:

- 1. Dimensions and tolerances are as per ANSI Y14.5M, 1982.
- 2. Package surface to be matte finish VDI 11~13.
- Die is facing up mold and facing down for trim/form, ie, reverse trim/form.
- 4. The foot length measuring is based on the gauge plane method.
- 5. Dimensions are exclusive of mold flash and gate burr.
- 6. Dimensions are exclusive of solder plating.
- 7. All dimensions are in mm.
- 8. This part is compliant with EIAJ spec. and JEDEC MO-178 AA
- 9. Lead span/stand off height/coplanarity are considered as special characteristic.

10° TYF



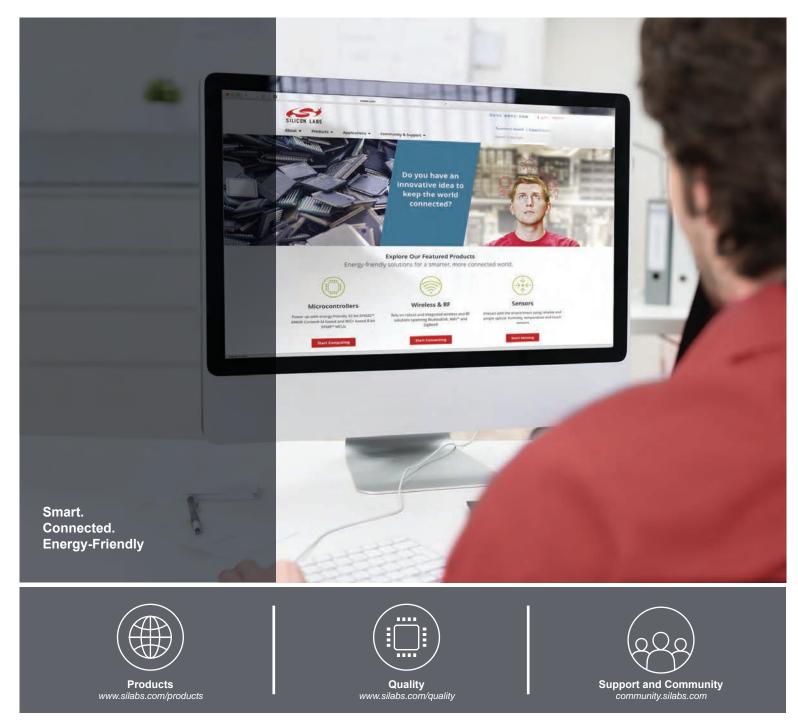


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Silicon Laboratories Inc. 400 West Cesar Chavez Austin, TX 78701 USA

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